

The Engineering Staff of
TEXAS INSTRUMENTS INCORPORATED
Semiconductor Group



**Bipolar
Memory
Data Manual**

SEPTEMBER 1977

TEXAS INSTRUMENTS
INCORPORATED

SCHOTTKY† PROMS

SERIES 54S/74S PROGRAMMABLE READ-ONLY MEMORIES

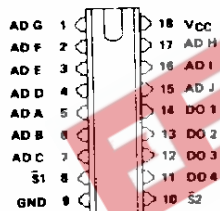
- Titanium-Tungsten (Ti-W) Fuse Links for Fast Low-Voltage Reliable Programming
- Full Decoding and Chip Select Simplify System Design
- Power-Down Versions ('S450, 'S451) Can Reduce System Power Requirements
- Fast Chip Select to Simplify System Decode

- Choice of Three-State or Open Collector Outputs
- PNP Inputs for Reduced Loading on System Buffers/Drivers
- Applications Include:
Microprogramming/Firmware Loaders
Code Converters/Character Generators
Translators/Emulators
Address Mapping/Look-Up Tables

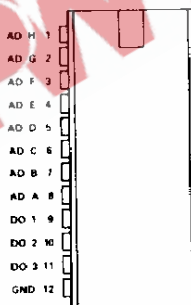
| TYPE NUMBER (PACKAGES) | | BIT SIZE (ORGANIZATION) | OUTPUT CONFIGURATION | TYPICAL PERFORMANCE | | |
|------------------------|------------------|----------------------------|-------------------------|---------------------|---------|----------------------|
| -55°C to 125°C | 0°C to 70°C | | | ACCESS TIME† | | POWER DISSIPATION |
| | | | | ADDRESS | SELECT | |
| SN54S450(J) | SN74S450(J,N) ✓ | 8192 bits | three-state | 45 ns | 20 ns | 600/100† mW |
| SN54S451(J) | SN74S451(J,N) ✓ | 1024 W x 8 B | open-collector | | | |
| SN54S478(J) | SN74S478(J,N) ✓ | 8192 bits | three-state | 45 ns | 20 ns † | 600 mW |
| SN54S479(J) | SN74S479(J,N) ✓ | 1024 W x 8 B | open-collector | | | |
| SN54S2708(J) | SN74S2708(J,N) ✓ | 8192 bits | three-state | 45 ns | 20 ns | 600 mW |
| SN54S3708(J) | SN74S3708(J,N) ✓ | 1024 W x 8 B | open-collector | | | |
| SN54S476(J) | SN74S476(J,N) ✓ | 4096 bits | three-state | 35 ns | 15 ns | 475 mW |
| SN54S477(J) | SN74S477(J,N) ✓ | 1024 W x 4 B | open-collector | | | |

†Power down

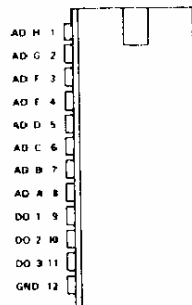
SN54S/74S476 3-S OUTPUTS
SN54S/74S477 0-C OUTPUTS
4096 BITS
(1024 WORDS BY 4 BITS)
'S476, 'S477



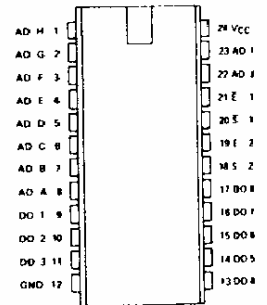
SN54S/74S478 3-S OUTPUTS
SN54S/74S479 0-C OUTPUTS
8192 BITS
(1024 WORDS BY 8 BITS)
'S478, 'S479



SN54S/74S2708 3-S OUTPUTS
SN54S/74S3708 0-C OUTPUTS
8192 BITS
(1024 WORDS BY 8 BITS)
'S2708, 'S3708



SN54S/74S450 3-S OUTPUTS
SN54S/74S451 0-C OUTPUTS
8192 BITS
(1024 WORDS BY 8 BITS)
'S450, 'S451



MAXIMUM DELAY TIMES

| TYPE | ADDRESS | EN | DISABLE |
|--------|---------|-------|---------|
| SN54S† | 75 ns | 40 ns | 40 ns |
| SN74S† | 60 ns | 30 ns | 30 ns |

description

These monolithic TTL programmable read-only memories (PROM's) features titanium-tungsten (Ti-W) fuse links with each link designed to program with a 100 microsecond pulse. They offer considerable flexibility for upgrading existing designs or improving new designs as they feature full Schottky clamping for improved performance, low-current MOS-compatible p-n-p inputs, and choice of bus-driving three-state or open-collector outputs. Additionally, the 'S450, 'S451 features dual enable/disable inputs which power-down or power-up the PROM providing additional cost effectiveness in power-sensitive applications. The power-down and power-up functions are sequenced to occur with the outputs at a high impedance.

Data can be electrically programmed, as desired, at any bit location in accordance with the programming procedure specified. These new PROM's are supplied with a high logic-level output condition stored at each bit location. The programming procedure open-circuits Ti-W metal links, which reverses the stored logic level at selected locations. The

DESIGN GOAL

This document provides tentative information on a product in the developmental stage. Texas Instruments reserves the right to change or discontinue this product without notice.

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†Integrated Schottky-Barrier diode-clamped transistor is patented by Texas Instruments, U. S. Patent Number 3,463,975.

SERIES 54S/74S PROGRAMMABLE READ-ONLY MEMORIES

Procedure is irreversible. Once altered, the output for that bit location is permanently programmed. Outputs never being altered may later be programmed to supply the opposite output level. Operation of the unit within the recommended operating conditions will not alter the memory content. Active level(s) at the chip-select(s) or memory enable (E) input(s) activates all of the outputs, and the 'S450, 'S451 memory enable will initiate a power-up sequence. An inactive level at any chip-select or memory enable input causes all outputs to be off, and the memory enable will initiate a power-down sequence. The three-state output offers the convenience of an open-collector output with the speed of a totem-pole output; it can be bus-connected to other similar outputs yet it retains the fast rise time characteristic of the TTL totem-pole output. The open-collector output offers the capability of direct interface with a line having a passive pull-up.

Maximum ratings over operating free-air temperature range (unless otherwise noted)

| | |
|---|----------------|
| Supply voltage | 7 V |
| Output voltage | 5.5 V |
| Off-state output voltage | 5.5 V |
| Operating free-air temperature range: SN54S' Circuits | -55°C to 125°C |
| SN74S' Circuits | 0°C to 70°C |
| Storage temperature range | -65°C to 150°C |

Recommended conditions for programming

| PARAMETER | 'S450, 'S451 | | | ALL OTHER TYPES | | | UNIT |
|--|----------------------|-----|-----|-----------------|-----|-----------------|------|
| | MIN | NOM | MAX | MIN | NOM | MAX | |
| Supply voltage, V_{CC} (See Note 1) | Steady state | | | 4.75 | 5 | 5.25 | V |
| | During programming | | | 5.75 | 6 | 6.25 | |
| Chip-select input voltage | High level, V_{IH} | | | 2.4 | 5 | 5 | V |
| | Low level, V_{IL} | | | 0.0 | 0.5 | 0.5 | |
| Memory enable input voltage, V_S | to disable | | | 9.75 | 10 | 10.25† | V |
| | to enable | | | 0.0 | 0.5 | 0.5 | |
| Logic level of all outputs except the one to be programmed | | | | 0.0 | 0.5 | 0.5 | V |
| Programming pulse applied to output to be programmed, $V_{O(pr)}$ (See Note 2) | | | | 16.75 | 17 | 17.25† | V |
| Programming ramp (10% to 90% times) | Rise time, t_r | | | 10‡ | 50 | 10‡ | μs |
| | Fall time, t_f | | | 10 | 10 | 10 | |
| Duration of $V_{O(pr)}$ programming pulse (See Figure 3) | | | | 98 | 100 | 10 ³ | μs |
| Programming duty cycle | | | | 25 | 35 | 25 | % |
| Operating temperature | | | | 0 | 55 | 55 | °C |

† Absolute maximum ratings.

‡ This minimum rise time applies only for the $V_{O(pr)}$ ramp.

- NOTES: 1. Voltage values are with respect to network ground terminal.
 2. All bit locations contain a high logic level and programming a bit changes the output of the bit to low logic level.
 3. Programming is guaranteed if the pulse applied is 98 μs in duration.

5-step programming procedure

1. Apply steady-state supply voltage and address the word to be programmed.
2. Enable the PROM and verify that the bit location needs to be programmed. If not, proceed to the next bit.
3. If the bit requires programming, increase V_{CC} by 1 volt (minimum current capability should be 200 mA) and disable the outputs by applying 10 volts to chip-select inputs. Minimum chip-select input current capabilities should be 5 mA.
4. Only one bit location is programmed at a time. Connect each output not being programmed to a 0 to 0.5 volt source. Apply the $V_{O(pr)}$ voltage pulse specified in the table to the output to be programmed. Minimum current capability of the programming output supply (during programming) should be 200 mA. See programming sequence of Figure 1.
5. After the X pulse is completed, disconnect the output that was programmed. Then, remove the 0 to 0.5 volt source from the remaining outputs.

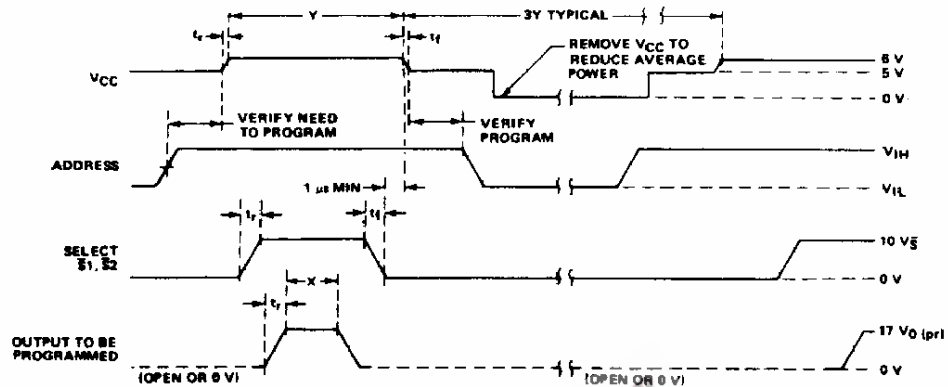
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SERIES 54S/74S

PROGRAMMABLE READ-ONLY MEMORIES

6. The chip-select inputs may be taken to a low logic level (to permit program verification).
7. One microsecond after the chip select input(s) reach low logic level V_{CC} should be decreased 1 V at which verification can be accomplished by measuring V_{OL} at the programmed output.
8. At a Y pulse duty cycle of 35% or less, repeat steps 1 through 7 for each output where it is desired to program a bit.

NOTE: Only one programming attempt per bit is recommended.



recommended operating conditions

| PARAMETER | 'S450 | | | 'S451 | | | 'S478, 'S2708 | | | 'S479, 'S3708 | | | 'S476 | | | 'S477 | | | UNIT | | |
|---------------------------------------|-------|-----|-----|-------|-------|-----|---------------|------|------|---------------|-----|------|-------|------|------|-------|------|------|------|------|----|
| | MIN | NOM | MAX | MIN | NOM | MAX | MIN | NOM | MAX | MIN | NOM | MAX | MIN | NOM | MAX | MIN | NOM | MAX | | | |
| Supply voltage, V_{CC} | SN54S | 5.8 | 6 | 6.5 | SN74S | 5.8 | 6 | 6.25 | 4.75 | 5 | 5.5 | 4.75 | 5 | 5.25 | 4.75 | 5 | 5.25 | 4.75 | 5 | 5.25 | V |
| High-level output current, I_{OH} | SN54S | | | -2 | SN74S | | | -3.2 | | | | | | | | | | | | | mA |
| Low-level output current, I_{OL} | | | 12 | | | | 12 | | | | 12 | | | | | | 16 | | | | mA |
| Operating free-air temperature, T_A | SN54S | -55 | | 125 | SN74S | 0 | | 70 | | | | | | | | | | | | | °C |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS† | 'S450, 'S476, 'S478, 'S2708 | | 'S451, 'S477, 'S479, 'S3708 | | UNIT |
|-----------|--|-----------------------------|------|--|-----|---------|
| | | MIN | TYP‡ | MAX | MIN | |
| V_{IH} | High-level input voltage | 2 | | | 2 | V |
| V_{IL} | Low-level input voltage | | | 0.8 | | 0.8 |
| V_{IK} | Input clamp voltage | | | $V_{CC} = \text{MIN}, I_I = -18 \text{ mA}$ | | -1.2 |
| V_{OH} | High-level output voltage | | | $V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OH} = \text{MAX}$ | | 2.4 3.4 |
| V_{OL} | Low-level output voltage | | | $V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OL} = \text{MAX}$ | | 0.5 |
| I_{OZH} | Off-state output current, high-level voltage applied | | | $V_{CC} = \text{MAX}, V_{IH} = 2 \text{ V}, V_O = 2.4 \text{ V}$ | | 50 |
| I_{OZL} | Off-state output current, low-level voltage applied | | | $V_{CC} = \text{MAX}, V_{IH} = 2 \text{ V}, V_O = 0.5 \text{ V}$ | | 50 |
| I_I | Input current at maximum input voltage | | | $V_{CC} = \text{MAX}, V_I = 5.5 \text{ V}$ | | 1 |
| I_{IH} | High-level input current | | | $V_{CC} = \text{MAX}, V_I = 2.7 \text{ V}$ | | 25 |
| I_{IL} | Low-level input current | | | $V_{CC} = \text{MAX}, V_I = 0.5 \text{ V}$ | | -250 |
| I_{OS} | Short-circuit output current§ | | | $V_{CC} = \text{MAX}$ | | -20 |
| | | | | SN54S | | -100 |
| | | | | SN74S | | -15 |
| I_{CC} | Supply current | | | $V_{CC} = \text{MAX}$ | | 95 140 |
| | | | | 4096-BIT PROM | | 95 140 |
| | | | | 8192-BIT PROM | | 120 |

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$.

§ Not more than one output should be shorted at a time and duration of the short circuit should not exceed one second.

DESIGN GOAL

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TTL MEMORIES

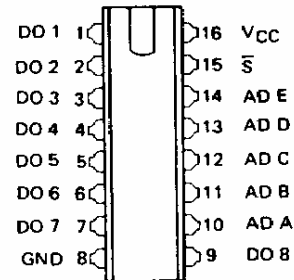
SERIES 54/74, 54S/74S READ-ONLY MEMORIES

BULLETIN NO. DLS 7512259, MAY 1975

- Mask-Programmed Memories That Can Replace PROMs
- Full On-Chip Decoding and Fast Chip Select(s) Simplify System Decoding
- All Schottky-Clamped ROMs Offer
 - Choice of 3-State or Open-Collector Outputs
 - P-N-P Inputs for Reduced Loading on System Buffers/Drivers
- Applications Include:
 - Microprogramming Firmware/Firmware Loaders
 - Code Converters/Character Generators
 - Translators/Emulators
 - Address Mapping/Look-Up Tables

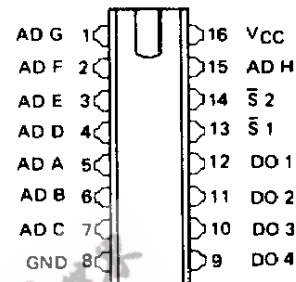
256 BITS (32 WORDS BY 8 BITS)

'88A



1024 BITS (256 WORDS BY 4 BITS)

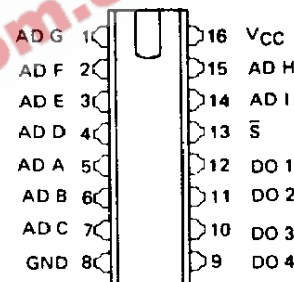
'187



| TYPE NUMBER (PACKAGES) | | TYPE OF OUTPUT(S) | BIT SIZE (ORGANIZATION) | TYPICAL ACCESS TIMES | |
|------------------------|----------------|-------------------|-------------------------|----------------------|---------|
| 35°C to 125°C | 0°C to 70°C | | | CHIP-SELECT | ADDRESS |
| I5488A(J, W) | SN7488A(J, N) | Open-Collector | 256 Bits (32 W x 8 B) | 22 ns | 26 ns |
| I54187(J, W) | SN74187(J, N) | Open-Collector | 1024 Bits (256 W x 4 B) | 20 ns | 40 ns |
| I54S270(J) X | SN74S270(J, N) | Open-Collector | 2048 Bits (512 W x 4 B) | 15 ns | 45 ns |
| I54S370(J) | SN74S370(J, N) | 3-State | 2048 Bits (256 W x 8 B) | 15 ns | 45 ns |
| I54S271(J) | SN74S271(J, N) | Open-Collector | | | |
| I54S371(J) | SN74S371(J, N) | 3-State | | | |

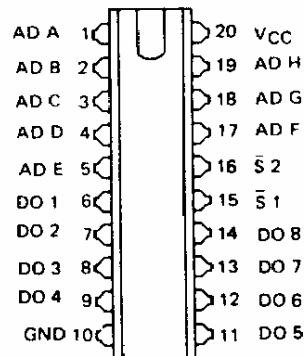
2048 BITS (512 WORDS BY 4 BITS)

'S270, 'S370



2048 BITS (256 WORDS BY 8 BITS)

'S271, 'S371



description

These monolithic TTL custom-programmed read-only memories (ROMs) are particularly attractive for applications requiring medium to large quantities of the same bit pattern. Plug-in replacements can be obtained for most of the popular TTL PROMs.

The high-complexity 2048-bit ROMs can be used to significantly improve system bit density for fixed memory as all are offered in compact 16- or 20-pin dual-in-line packages having pin-row spacings of 0.300-inch.

The Schottky-clamped versions offer considerable flexibility for upgrading existing designs or improving new designs as they feature improved performance; plus, they offer low-current MOS-compatible p-n-p inputs, choice of bus-driving three-state or open-collector outputs, and improved chip-select access times.

Data from a sequenced deck of data cards punched according to the specified format are permanently programmed by the factory into the monolithic structure for all bit locations. Upon receipt of the order, Texas Instruments will assign a special identifying number for each pattern programmed according to the order. The completed devices will be marked with the appropriate TI special device number. It is important that the customer specify not only the output levels desired at all bit locations, but also the other information requested under ordering instructions.

The three-state outputs offer the convenience of an open-collector output with the speed of a totem-pole output: they can be bus-connected to other similar outputs yet they retain the fast rise time characteristic of the TTL totem-pole output. The open-collector outputs offer the capability of direct interface with a data line having a passive pull-up.

Word-addressing is accomplished in straight positive-logic binary and the memory may be read when all \bar{S} inputs are low. A high at any \bar{S} input causes the outputs to be off.

Pin assignments for all of these memories are the same for all packages.

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Integrated Schottky-Barrier diode-clamped transistor is patented by Texas Instruments. U. S. Patent Number 3,463,976.